

General Description

The MDP11N60 uses advanced Magnachip's MOSFET Technology, which provides low on-state resistance, high switching performance and excellent quality.

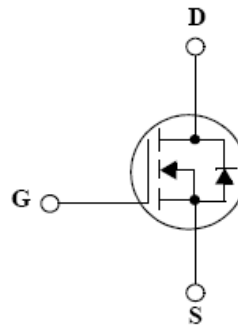
MDP11N60 is suitable device for SMPS, high Speed switching and general purpose applications.

Features

- $V_{DS} = 600V$
- $V_{DS} = 660V$
- $I_D = 11A$ @ $V_{GS} = 10V$
- $R_{DS(ON)} \leq 0.55\Omega$ @ $V_{GS} = 10V$

Applications

- Power Supply
- PFC
- High Current, High Speed Switching



Absolute Maximum Ratings (Ta = 25°C)

| Characteristics | | Symbol | Rating | Unit |
|--|--------------------|----------------------|---------|------|
| Drain-Source Voltage | | V_{DSS} | 600 | V |
| Drain-Source Voltage @ T_{jmax} | | $V_{DSS} @ T_{jmax}$ | 660 | V |
| Gate-Source Voltage | | V_{GSS} | ±30 | V |
| Continuous Drain Current (※) | $T_C=25^\circ C$ | I_D | 11 | A |
| | $T_C=100^\circ C$ | | 6.9 | A |
| Pulsed Drain Current ⁽¹⁾ | | I_{DM} | 44 | A |
| Power Dissipation | $T_C=25^\circ C$ | P_D | 182 | W |
| | Derate above 25 °C | | 1.45 | W/°C |
| Peak Diode Recovery dv/dt ⁽³⁾ | | Dv/dt | 4.5 | V/ns |
| Single Pulse Avalanche Energy ⁽⁴⁾ | | E_{AS} | 720 | mJ |
| Junction and Storage Temperature Range | | T_J, T_{stg} | -55~150 | °C |

※ I_D limited by maximum junction temperature

Thermal Characteristics

| Characteristics | Symbol | Rating | Unit |
|--|-----------------|--------|------|
| Thermal Resistance, Junction-to-Ambient ⁽¹⁾ | $R_{\theta JA}$ | 62.5 | °C/W |
| Thermal Resistance, Junction-to-Case ⁽¹⁾ | $R_{\theta JC}$ | 0.69 | |

Ordering Information

| Part Number | Marking | Temp. Range | Package | Packing | RoHS Status |
|-------------|----------|-------------|---------|---------|--------------|
| MDP11N60TH | MDP11N60 | -55~150°C | TO-220 | Tube | Halogen Free |

Electrical Characteristics (Ta =25°C)

| Characteristics | Symbol | Test Condition | Min | Typ | Max | Unit |
|--|--------------|--|-----|------|------|----------|
| Static Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV_{DSS} | $I_D = 250\mu A, V_{GS} = 0V$ | 600 | - | - | V |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 3.0 | - | 5.0 | |
| Drain Cut-Off Current | I_{DSS} | $V_{DS} = 600V, V_{GS} = 0V$ | - | - | 1 | μA |
| Gate Leakage Current | I_{GSS} | $V_{GS} = \pm 30V, V_{DS} = 0V$ | - | - | 100 | nA |
| Drain-Source ON Resistance | $R_{DS(ON)}$ | $V_{GS} = 10V, I_D = 5.5A$ | | 0.45 | 0.55 | Ω |
| Forward Transconductance | g_{fs} | $V_{DS} = 30V, I_D = 5.5A$ | - | 13 | - | S |
| Dynamic Characteristics | | | | | | |
| Total Gate Charge | Q_g | $V_{DS} = 480V, I_D = 11A, V_{GS} = 10V^{(3)}$ | - | 38.4 | - | nC |
| Gate-Source Charge | Q_{gs} | | - | 11.2 | - | |
| Gate-Drain Charge | Q_{gd} | | - | 14 | - | |
| Input Capacitance | C_{iss} | $V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz$ | - | 1700 | | pF |
| Reverse Transfer Capacitance | C_{rss} | | - | 6.2 | | |
| Output Capacitance | C_{oss} | | - | 184 | | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{GS} = 10V, V_{DS} = 300V, I_D = 11A, R_G = 25\Omega^{(3)}$ | - | 38 | | ns |
| Rise Time | t_r | | - | 50 | | |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 76 | | |
| Fall Time | t_f | | - | 33 | | |
| Drain-Source Body Diode Characteristics | | | | | | |
| Maximum Continuous Drain to Source Diode Forward Current | I_S | | - | 11 | - | A |
| Source-Drain Diode Forward Voltage | V_{SD} | $I_S = 11A, V_{GS} = 0V$ | - | | 1.4 | V |
| Body Diode Reverse Recovery Time | t_{rr} | $I_F = 11A, di/dt = 100A/\mu s^{(3)}$ | - | 430 | | ns |
| Body Diode Reverse Recovery Charge | Q_{rr} | | - | 4.0 | | μC |

Note :

- Pulse width is based on $R_{\theta JC}$ & $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C.
- Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$, pulse width limited by junction temperature $T_{J(MAX)} = 150^\circ C$.
- $I_{SD} \leq 11.0A$, $di/dt \leq 200A/\mu s$, $V_{DD} = 50V$, $R_G = 25\Omega$, Starting $T_J = 25^\circ C$
- $L = 10.9mH$, $I_{AS} = 11A$, $V_{DD} = 50V$, $R_G = 25\Omega$, Starting $T_J = 25^\circ C$

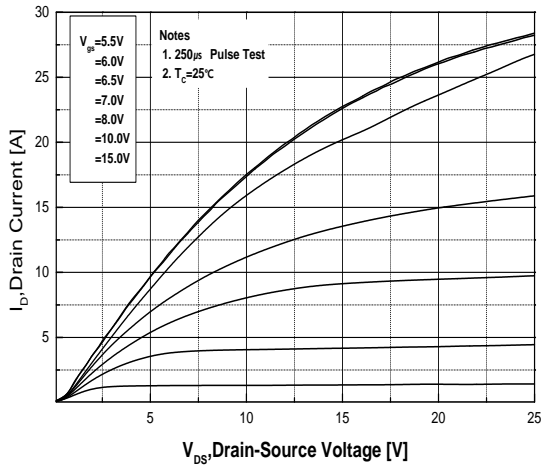


Fig.1 On-Region Characteristics

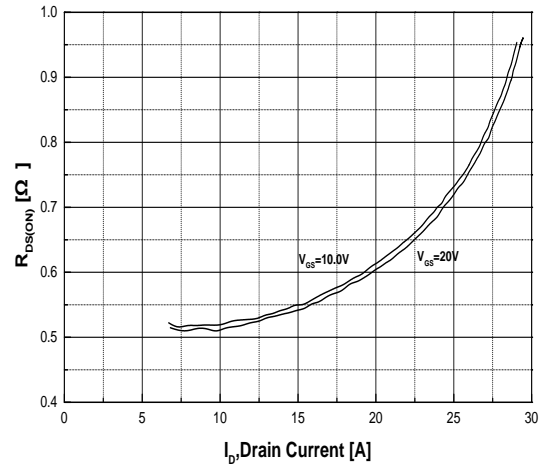


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

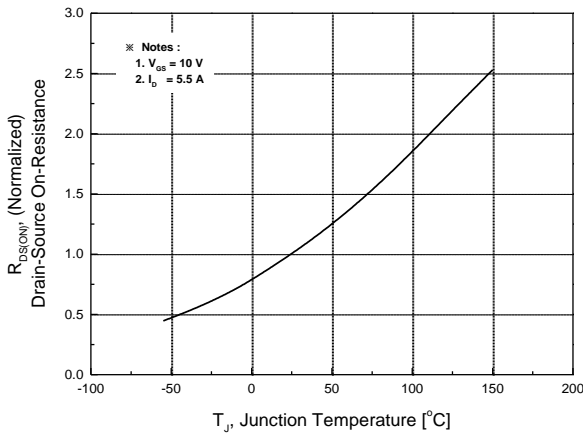


Fig.3 On-Resistance Variation with Temperature

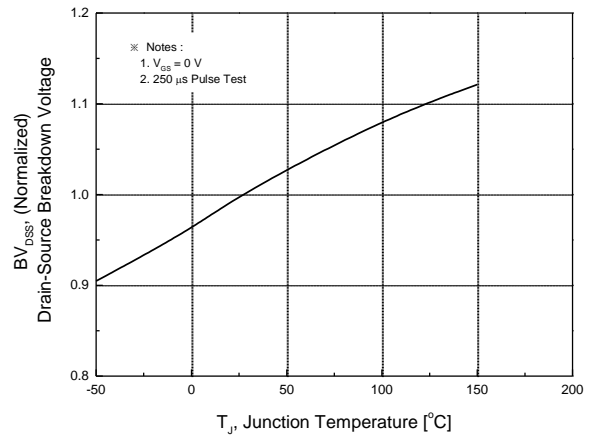


Fig.4 Breakdown Voltage Variation vs. Temperature

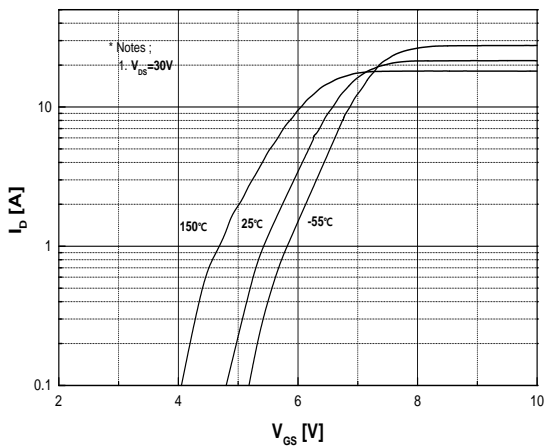


Fig.5 Transfer Characteristics

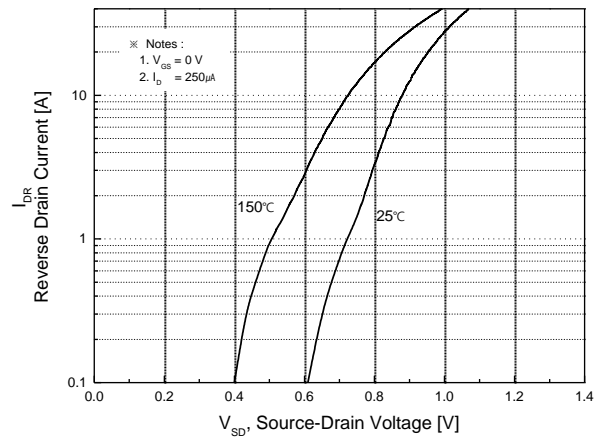


Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature

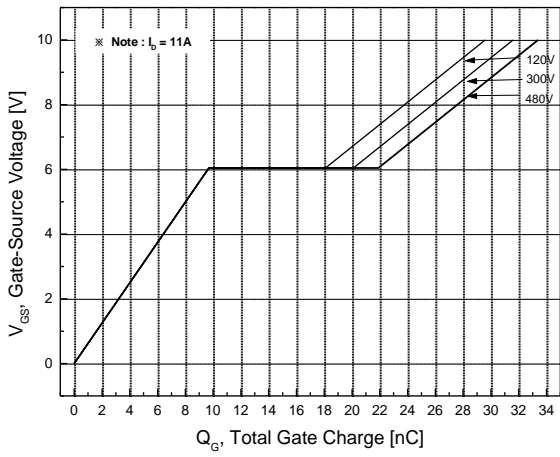


Fig.7 Gate Charge Characteristics

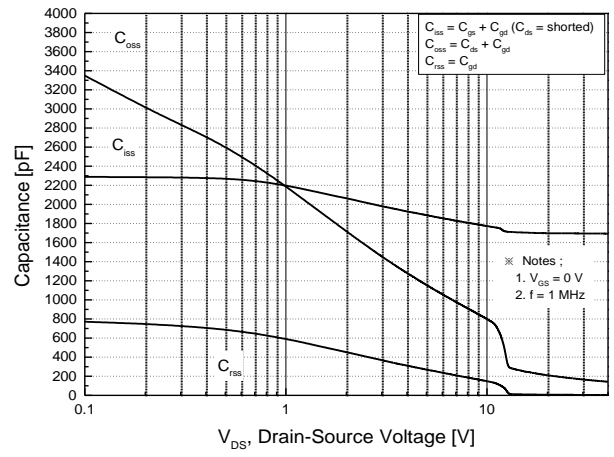


Fig.8 Capacitance Characteristics

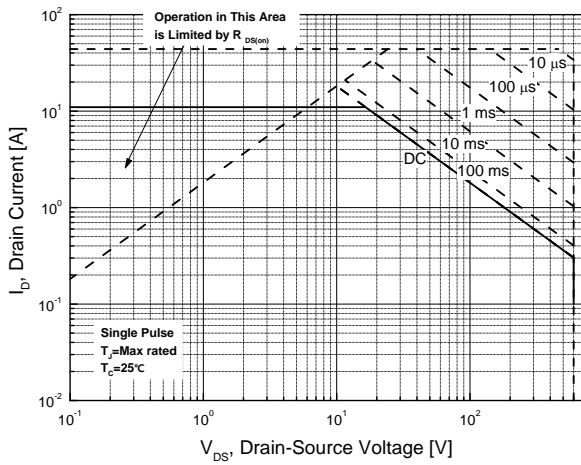


Fig.9 Maximum Safe Operating Area

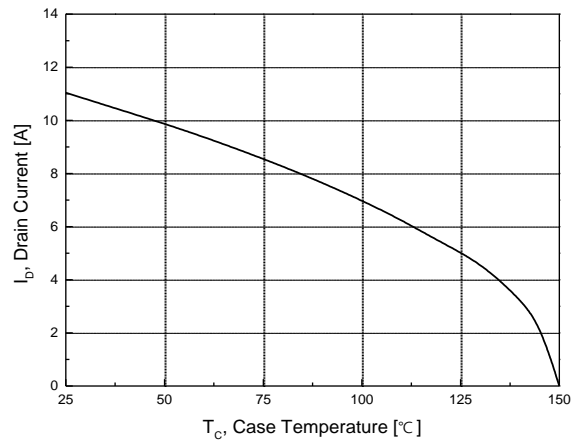


Fig.10 Maximum Drain Current vs. Case Temperature

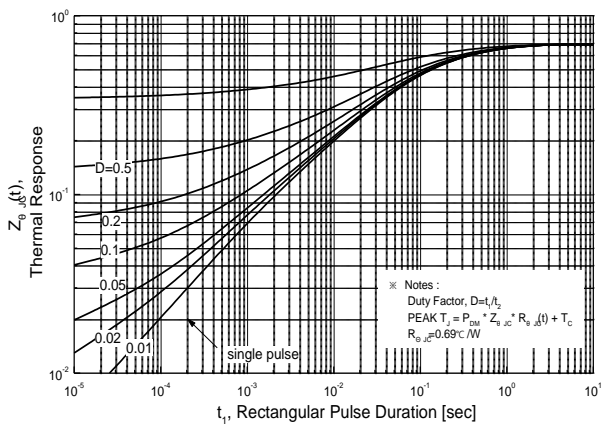


Fig.11 Transient Thermal Response Curve

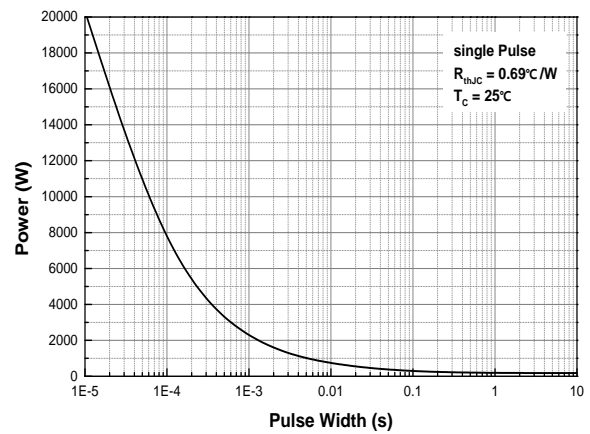
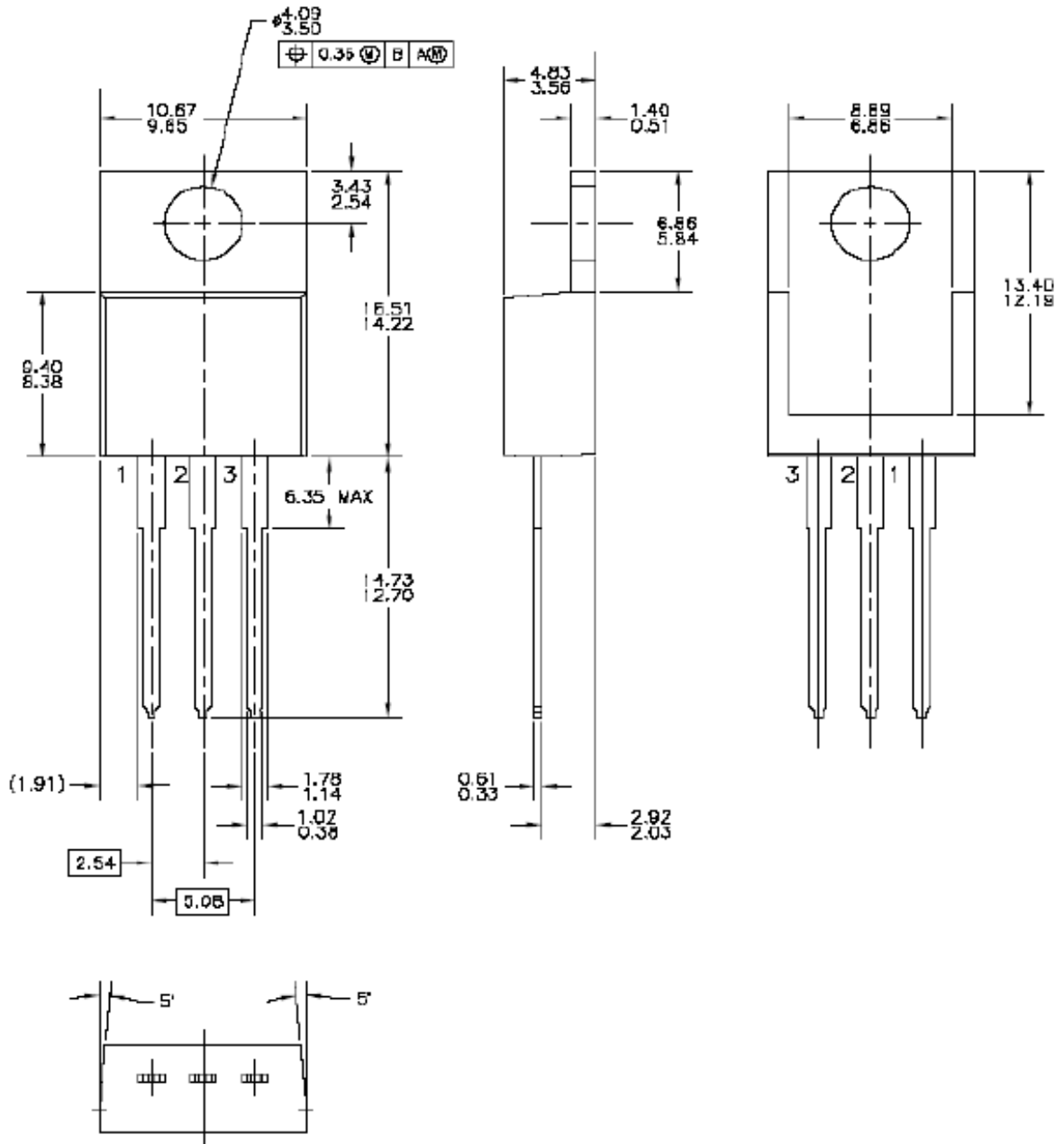


Fig.12 Single Pulse Maximum Power Dissipation

Physical Dimensions


TO-220

MDP11N60 N-channel MOSFET 600V



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